## Notice of References Cited Application/Control No. 10/657,182 Examiner Chen-Wen Jiang Applicant(s)/Patent Under Reexamination HIWATA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,516,920 A	05-1985	Shibuya, Tsunenori	418/23
	В	US-6,178,761 B1	01-2001	Karl, Stefan	62/159
	С	US-			·
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 2544232 A	07-1976	Germany		F01C 01/34
	0	JP 2001066006 A	03-2001	Japan	ISHIDA, SATOSHI	F25B 13/00
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Y *				
	V					
	w					
	X	· *				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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